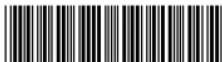


Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10734164	CHANG, DEUK-HWAN
Examiner	Art Unit	
Cheukfan Lee	2625	

SEARCHED

Class	Subclass	Date	Examiner
358	496,498,494,505,474,492	3/31/2008	C.Lee
399	377,378	3/31/2008	C.Lee
355	75	3/31/2008	C.Lee

SEARCH NOTES

Search Notes	Date	Examiner
EAST search: Inventor search, see history	3/31/2008	C.Lee

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
358	496,498,494,474	3/31/2008	C.Lee